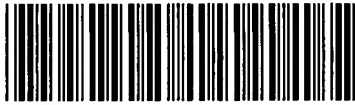


**Search Notes**

Application/Control No.

10/536,556

Examiner

HIEU T. VO

Applicant(s)/Patent under  
Reexamination

SCHMIDT ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
701	114 110 102 115	8/18/2007	VH
123	435	8/18/2007	VH
73	117.3	8/18/2007	VH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
All of above		8/18/2007	VH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	8/18/2007	VH